

FCC TEST REPORT (PART 24)

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1 CERTIFICATION

PRODUCT : Pocket PC phone MODEL : VOGU100 APPLICANT : High Tech Computer Corp. TESTED : Jun. 21 ~ Jun. 27, 2007 TEST SAMPLE : ENGINEERING SAMPLE TEST STANDARDS : FCC Part 24, Subpart E ANSI C63.4-2003

The above equipment (model: VOGU100) has been tested by **Advance Data Technology Corporation**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

: Zimie Sang, DATE: Jul. 03, 2007 Rennie Wang / Senior Specialist PREPARED BY TECHNICAL ACCEPTANCE : Long Chen , DATE: Jul. 03, 2007 Responsible for RF Long Chen / Senior Engineer APPROVED BY : <u>Gary Charg</u>, DATE: Jul. 03, 2007 Gary Chang / Supervisor



2 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

	APPLIED STANDARD: FCC Part 24 & Part 2 / IC RSS-133					
STANDARD SECTION	TEST TYPE AND LIMIT	RESULT	REMARK			
2.1046 24.232	Maximum Peak Output Power Limit: max. 2 watts e.i.r.p peak power	PASS	Meet the requirement of limit. Minimum passing margin is 24.85dBm at 1851.25MHz.			
2.1055 24.235	Frequency Stability AFC Freq. Error vs. Voltage AFC Freq. Error vs. Temperature Limit: max. ±2.5ppm	PASS	Meet the requirement of limit.			
2.1049 24.238(b)	Occupied Bandwidth	PASS	Meet the requirement of limit.			
24.238(b)	Band Edge Measurements	PASS	Meet the requirement of limit.			
2.1051 24.238	Conducted Spurious Emissions	PASS	Meet the requirement of limit.			
2.1053 24.238	Radiated Spurious Emissions	PASS	Meet the requirement of limit. Minimum passing margin is –49.97dB at 825.11MHz.			



2.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4:

MEASUREMENT	FREQUENCY	UNCERTAINTY
Conducted emissions	9kHz ~ 30MHz	2.44dB
Radiated emissions	30MHz ~ 200MHz	3.34dB
	200MHz ~1000MHz	3.35dB
	1GHz ~ 18GHz	2.26dB
	18GHz ~ 40GHz	1.94dB

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k = 2.



3 GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

PRODUCT	Pocket PC phone
MODEL NO.	VOGU100
FCC ID	NM8VOGU100
POWER SUPPLY	3.7Vdc from rechargeable lithium battery5.0Vdc from power adapter5.0Vdc from host equipment
MODULATION TYPE	OQPSK, HPSK
FREQUENCY RANGE	1850MHz ~ 1910MHz
NUMBER OF CHANNEL	1151
MAX. CONDUCTED PEAK OUTPUT POWER	23.70dBm (0.234Watts)
MAX. EIRP POWER	24.85dBm (0.305Watts)
ANTENNA TYPE	Monopole antenna with 0dBi gain
DATA CABLE	1.6m USB shielded cable without core
I/O PORTS	Refer to user's manual
ASSOCIATED DEVICES	Refer to NOTE below
EUT EXTREME VOL. RANGE	3.6Vdc to 4.2Vdc

NOTE:

- 1. The applicant defined the normal working voltage of the battery is from 3.6Vdc to 4.2Vdc.
- 2. The EUT is a CDMA2000 (850/1900) + 1xEVDO/ 1xRTT/ IS-95A/B Pocket PC phone with bluetooth V2.0 w EDR + AGPS functions. This report is only covered the function of CDMA1900. The bluetooth function is covered in another test report, which standard used is FCC Part 15. And the CDMA850 mobile phone function is covered in another test report, which standard used is FCC Part 22.
- 3. The EUT has following accessories.

ACCESSORY	BRAND	MODEL	SUPPORTER	REMARKS
Belt Clip	HTC	PO S292	NEWTECH	
Carrying Case	HTC	PO S290	NEWTECH	
Earphone	HTC	HS S190	Merry	
Splitter (1)	HTC	YC A130	MEC	10.5cm (earphone with audio interface)
Splitter (2)	HTC	YC A100	Acon	9.7cm (earphone with USB interface)



4.	The communicated functions of EUT listed as below:
----	--

		850MHz	1900MHz	
	CDMA	V	V	With bluetooth
3G	1xEVDO	V	-	V2.0 w EDR +
	1xRTT	V	V	AGPS functions
	IS-95A/B	V	V	

5. The EUT has lithium batteries listed as below:

BRAND: TWS MODEL: ELF0160 RATING: 3.7Vdc, 1100mAh	BATTERY A:	
	BRAND:	TWS
RATING: 3.7Vdc. 1100mAh	MODEL:	ELF0160
	RATING:	3.7Vdc, 1100mAh

BATTERY B:		
BRAND:	SAMSUNG	
MODEL:	ELF0160	
RATING:	3.7Vdc, 1100mAh	

NOTE: After pre-tested both batteries, found battery A is worse, therefore all the test results came out from this.

6. The EUT was operated with following power adapters:

ADAPTER 1:	ADAPTER 1:			
BRAND:	DELTA ELECTRONIC, INC.			
MODEL:	ADP-5FH B			
INPUT:	100-240Vac, 0.2A, 50~60Hz			
OUTPUT:	5Vdc, 1A			
POWER LINE:	DC 1.8m non-shielded cable without core			

ADAPTER 2:	
BRAND:	htc
MODEL:	PSAA05A-050
INPUT:	100-240Vac, 200mA, 50-60Hz
OUTPUT:	5.0Vdc, 1A
POWER LINE:	DC 1.8m non-shielded cable without core

7. Refer to following table for ESN no.:

ESN NO.	
36AD00**	

8. The above EUT information was declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or User's Manual.



3.2 DESCRIPTION OF TEST MODES

1151 channels are provided to this EUT in the CDMA1900 band. Therefore, the low, middle and high channels are chosen for testing.

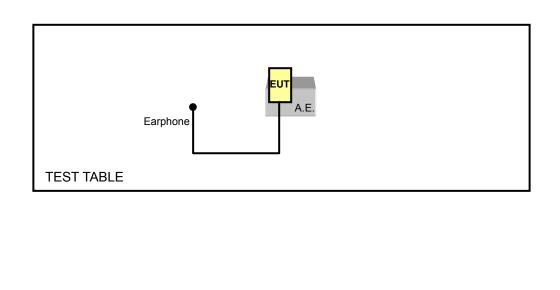
	CHANNEL	FREQUENCY	TX MODE
LOW	25	1851.25 MHz	SO55
MIDDLE	600	1880.00 MHz	SO55
HIGH	1175	1908.75 MHz	SO55

NOTE:

1. Below 1 GHz, the channel 25, 600 and 1175 were pre-tested in chamber. The channel 25 was the worst case and chosen for final test.

- 2. Above 1 GHz, the channel 25, 600 and 1175 were tested individually.
- 3. The channel space is 0.05MHz.
- 4. Since the EUT is considered a handheld unit, it was pre-tested on the positioned of each 3 axis. The worst case was found when positioned on Z-plane. Therefore only the test data of this Z-plane was used for radiated emission measurement test.
- 5. In this report, CDMA2000 (SO55) was the worst case for all test items, therefore, only the data was recorded in the following section.

3.2.1 CONFIGURATION OF SYSTEM UNDER TEST





3.2.2 TEST MODE APPLICABILITY AND TESTED CHANNEL DETAIL

EUT	APPLICABLE TO						DESCRIPTION	
CONFIGURE MODE	OP	P FS OB BE		BE	CE	RE<1G	RE≥1G	DESCRIPTION
-	- V V V V V V			-				
Where OP: C	Where OP : Output power FS : Frequency stability							
OB : C	Occupied ba	andwidth			BE: Band	edge		
CE : C	onducted s	spurious er	missions		RE<1G: F	Radiated er	mission be	low 1GHz
RE≥1	G: Radiate	d emissior	above 1G	Hz				
OUTPUT POWER MEASUREMENT:								
Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, xyz axis and antenna ports (if EUT with antenna diversity architecture).								
🛛 Following	g channe	l(s) was	(were) s	elected f	or the fin	al test a	s listed b	elow.

EUT CONFIGI MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY	AXIS
-	25 to 1175	25, 600, 1175	CDMA	Z

FREQUENCY STABILITY MEASUREMENT:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EU CONFIG MOD	URE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY
-		25 to 1175	25	CDMA



OCCUPIED BANDWIDTH MEASUREMENT:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY
-	25 to 1175	25, 600, 1175	CDMA

BAND EDGE MEASUREMENT:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY
-	25 to 1175	25, 1175	CDMA

CONDUCTED SPURIOUS EMISSIONS MEASUREMENT:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY
-	25 to 1175	25, 600, 1175	CDMA



RADIATED EMISSION MEASUREMENT (BELOW 1 GHz):

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, xyz axis and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY	AXIS
-	25 to 1175	25	CDMA	Z

RADIATED EMISSION MEASUREMENT (ABOVE 1 GHz):

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, xyz axis and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT CONFIGURE MODE	AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TECHNOLOGY	AXIS
-	25 to 1175	25, 600, 1175	CDMA	Z



3.3 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT is a RF product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC 47 CFR Part 2 FCC 47 CFR Part 24 IC RSS-133 ANSI C63.4-2003 ANSI/TIA/EIA-603-A

NOTE: All test items have been performed and recorded as per the above standards.

3.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

NO.	PRODUCT	BRAND	MODEL NO.	SERIAL NO.	CAL. DATE
1	Universal Radio Communication Tester	R&S	CMU200	104484	Apr. 11, 2008

NO.	SIGNAL CABLE DESCRIPTION OF THE ABOVE SUPPORT UNITS
1	NA

NOTE: All power cords of the above support units are non shielded (1.8m).



4 TEST TYPES AND RESULTS

4.1 OUTPUT POWER MEASUREMENT

4.1.1 LIMITS OF OUTPUT POWER MEASUREMENT

The radiated peak output power shall be according to the specific rule Part 24.232(b) that "Mobile / Portable station are limited to 2 watts e.i.r.p" and 24.232(c) specific that "Peak transmit power must be measure over any interval of continuous transmission using instrumentation calibration in terms of rms-equivalent voltage."



4.1.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
Test Receiver ROHDE & SCHWARZ	ESCI	100424	Aug 04, 2007
Spectrum Analyzer ROHDE & SCHWARZ	FSP40	100025	Oct. 05, 2007
BILOG Antenna SCHWARZBECK	VULB9168	9168-160	May 31, 2008
HORN Antenna SCHWARZBECK	9120D	9120D-209	Jun. 28, 2008
HORN Antenna SCHWARZBECK	BBHA 9170	BBHA9170243	Dec. 28, 2007
Preamplifier Agilent	8447D	2944A10633	Oct. 26, 2007
Preamplifier Agilent	8449B	3008A01964	Oct. 26, 2007
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	238137/4	Dec. 11, 2007
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	233233/4	Nov. 14, 2007
Software ADT.	ADT_Radiated_V7.6	NA	NA
Antenna Tower inn-co GmbH	MA 4000	013303	NA
Antenna Tower Controller inn-co GmbH	CO2000	017303	NA
Turn Table ADT.	TT100.	TT93021703	NA
Turn Table Controller ADT.	SC100.	SC93021703	NA

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Chamber 3.

3. The horn antenna and HP preamplifier (model: 8449B) are used only for the measurement of emission frequency above 1GHz if tested.

- 4. The VCCI Site Registration No. is R-237.
- 5. The IC Site Registration No. is IC3789B-3.



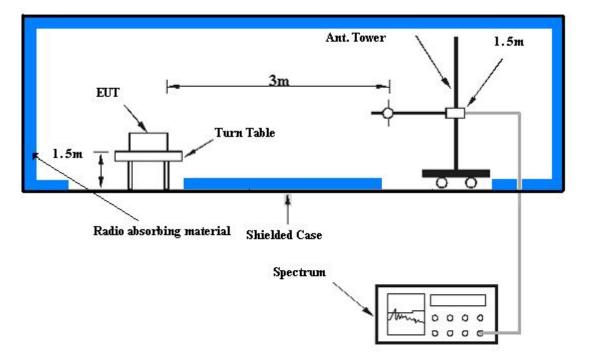
4.1.3 TEST PROCEDURES

- a. The EUT was set up for the maximum peak power with CDMA link data modulation. The power was measured with R&S Spectrum Analyzer. All measurements were done at 3 channels: 25, 600 and 1175 (low, middle and high operational frequency range).
- b. The conducted peak output power used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer. The path loss included the splitter loss, cable loss and 20dB pad loss. The spectrum set RB/VB 3MHz, then read peak power value and record to the test. (All transmitted path loss shall be considered in the test report data.)
- c. E.I.R.P peak power measurement. In the fully anechoic chamber, EUT placed on the 1.5m height of Turn Table, rotated the table around 360 degrees to search the maximum radiation power and receiver antenna shall be rotated vertical and horizontal polarization to find the maximum polar radiated power. The "Read Value" is the spectrum reading the maximum power value.
- d. The substitution horn antenna is substituted for EUT at the same position and signal generator export the CW signal to the calibration antenna. Rotated the Turn Table to find the maximum radiation power. "Raw" is the spectrum reading value, "SG" is signal generator export power, "TX Gain" is calibration antenna isotropic gain value, "TX cable" is the transmitted cable loss between the calibration antenna and signal generator. The "Factor" means that the transmission path loss is equal to "SG" - "TX cable" + "TX Gain" – "Raw".
- e. Actually the real E.I.R.P peak power is equal to "Read Value" + "Factor".



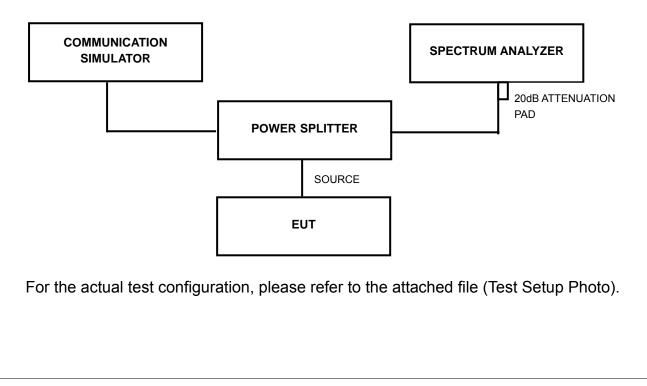
4.1.4 TEST SETUP

EIRP POWER MEASUREMENT:



For the actual test configuration, please refer to the attached file (Test Setup Photo).

CONDUCTED POWER MEASUREMENT:





4.1.5 EUT OPERATING CONDITIONS

- a. The EUT makes a phone call to the communication simulator.
- b. The communication simulator station system controlled an EUT to export maximum output power under transmission mode and specific channel frequency.



4.1.6 TEST RESULTS

MODE	IX connected	DETECTOR FUNCTION	Average
INPUT POWER (SYSTEM)	120Vac, 60Hz		22deg. C, 60%RH, 983hPa
TESTED BY	Match Tsui		

CONDUCTED POWER (1x EV-DO)										
	FREQ.	RAW VALUE (dBm)		RAW VALUE (CORR.		PEAK OUT	PUT POWER	
CHANNEL	(MHz)				RTAP FT/		ТАР			
		RTAP	FTAP	'AP	dBm	Watt	dBm	Watt		
25	1851.25	18.21	18.38	5.00	23.21	0.209	23.38	0.218		
600	1880.00	18.20	18.42	5.00	23.20	0.209	23.42	0.220		
1175	1908.75	18.22	18.36	5.00	23.22	0.210	23.36	0.217		

	CDMA 2000 CONDUCTED POWER (SO2, SO55, TDSO SO32, SO3)										
	FREQ.	CDMA 2000	RAW VALUE (dBm)			CORR.	PEAK	OUTPUT	POWER	(dBm)	
CHAN.	(MHz)	RC	SO2	SO55	TDSO SO32	SO3	FACTOR (dB)	SO2	SO55	TDSO SO32	SO3
25	1851.25	RC1	18.35	18.41	-	18.35	5.00	23.35	23.41	-	23.35
23	1001.20	RC3	18.41	18.58	18.36	18.42	5.00	23.41	23.58	23.36	23.42
600	1880.00	RC1	18.64	18.62	-	18.67	5.00	23.64	23.62	-	23.67
000	1000.00	RC3	18.66	18.70	18.64	18.68	5.00	23.66	23.70	23.64	23.68
1175	1908.75	RC1	18.61	18.59	-	18.61	5.00	23.61	23.59	-	23.61
1175	1900.75	RC3	18.62	18.69	18.63	18.66	5.00	23.62	23.69	23.63	23.66

REMARKS: 1. Peak Output Power (dBm) = Raw Value (dBm) + Correction Factor (dB).

2. Correction Factor (dB) = Power Splitter Loss (dB) + Cable Loss (dB).

3. The value in bold is the worst.



MODE	TX connected	DETECTOR FUNCTION	Average
INPUT POWER (SYSTEM)	120Vac, 60Hz		22deg. C, 60%RH, 983hPa
TESTED BY	Match Tsui		

	EIRP POWER (1x EV-DO)								
		FREQ.	RAW VALUE (dBm)		CORR.		PEAK OUT	PUT POWER	
CHA	NNEL	(MHz)			FACTOR (dB)	RT	RTAP		FTAP
			RTAP	FTAP	Р	dBm	Watt	dBm	Watt
2	25	1851.25	-15.68	-15.52	40.03	24.35	0.272	24.51	0.282
6	60	1880.00	-16.66	-16.51	40.32	23.66	0.232	23.81	0.240
11	175	1908.75	-18.51	-18.37	40.62	22.11	0.163	22.25	0.168

EIRP POWER (SO55)							
CHANNEL NO.	FREQUENCY (MHz) RAW VALUE (dBm)		CORRECTION	PEAK OUTPUT POWER			
	,		FACTOR (dB)	dBm	Watt		
25	1851.25	-15.18	40.03	24.85	0.305		
600	1880.00	-16.16	40.32	24.16	0.261		
1175	1908.75	-17.85	40.62	22.77	0.189		

REMARKS: 1. Peak Output Power (dBm) = Raw Value (dBm) + Correction Factor (dB).

2. Correction Factor (dB) = Receiver Antenna Gain (dBi) + Cable Loss (dB) + Free Space Loss (dB).

3. The value in bold is the worst.



4.2 FREQUENCY STABILITY MEASUREMENT

4.2.1 LIMITS OF FREQUENCY STABILIITY MEASUREMENT

According to the FCC part 2.4235 shall be tested the frequency stability. The rule is defined that" The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block." The frequency error rate is according to the JTC standard that the frequency error rate shall be accurate to within 2.5ppm of the received frequency from the base station. The test extreme voltage is according to the 2.1055(d)(1) Vary primary supply voltage from 85 to 115 percent of the nominal value for other than hand carried battery equipment and the extreme temperature rule is comply with the 2.1055(a)(1) –30°C ~50°C.

4.2.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
* Hewlett Packard RF cable	8120-6192	01428251	NA
* Suhner RF cable	Sucoflex104	204850/4	NA
* WIT Standard Temperature & Humidity Chamber	TH-4S-C	W981030	Jul. 10, 2007

NOTE: 1. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.

2. "*" = These equipments are used for the final measurement.

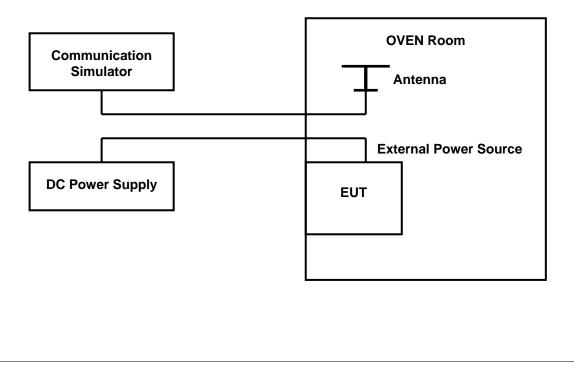
3. The test was performed in ADT RF OVEN room.



4.2.3 TEST PROCEDURE

- a. Because of the measure the carrier frequency under the condition of the AFC lock, it shall be used the mobile station in the CDMA link mode. This is accomplished with the use of the communication simulator station. The oven room could control the temperatures and humidity. The link channel is the 9538.
- b. Power must be removed when changing from one temperature to another or one voltage to another voltage. Power warm up is at least 15 min and power applied should perform before recording frequency error.
- c. EUT is connected the external power supply to control the DC input power. The various Volts from the minimum 3.6 Volts to 4.2 Volts. Each step shall be record the frequency error rate.
- d. The temperature range step is 10 degrees in this test items. All temperature levels shall be hold the $\pm 0.5^{\circ}$ C during the measurement testing.
- e. The each temperature step shall be at least 0.5 hours, consider the EUT could be test under the stability condition.

NOTE: The frequency error was recorded frequency error from the communication simulator.



4.2.4 TEST SETUP



4.2.5 TEST RESULTS

MODE	Channel 25		22deg. C, 60%RH, 983hPa
INPUT POWER (SYSTEM)	120Vac, 60Hz	TESTED BY	Match Tsui

AFC FREQUENCY ERROR vs. VOLTAGE					
VOLTAGE (Volts) FREQUENCY ERROR (Hz) FREQUENCY ERROR (ppm) LIMIT (ppm)					
3.6	16	0.0119545726	2.5		
4.2	14	0.0131500299	2.5		

	AFC FREQUENCY ERROR vs. TEMP.						
ТЕМР. (°С)	FREQUENCY ERROR (Hz)	FREQUENCY ERROR (ppm)	LIMIT (ppm)				
50	17	0.0191273162	2.5				
40	15	0.0167364017	2.5				
30	14	0.0155409444	2.5				
20	12	0.0131500299	2.5				
10	12	0.0095636581	2.5				
0	15	0.0107591154	2.5				
-10	16	0.0119545726	2.5				
-20	17	0.0143454871	2.5				
-30	18	0.0155409444	2.5				



4.3 OCCUPIED BANDWIDTH MEASUREMENT

4.3.1 LIMITS OF OCCUPIED BANDWIDTH MEASUREMENT

According to FCC 24.238(b) specified that emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26dB below the transmitter power.

4.3.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
* ROHDE & SCHWARZ	FSP40	100035	Mar. 25, 2008
Spectrum Analyzer			
* Mini-Circuits Power Splitter	ZAPD-4	400005	NA
* Hewlett Packard RF cable	8120-6192	01428251	NA
* JFW 20dB attenuation	50HF-020-SMA	NA	NA
* Suhner RF cable	Sucoflex104	204850/4	NA

NOTE: 1. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.

2. "*" = These equipments are used for the final measurement.

4.3.3 TEST SETUP

Same as Item 4.2.4 (Conducted Power Setup)



4.3.4 TEST PROCEDURES

- a. The EUT makes a phone call to the communication simulator. The power was measured with R&S Spectrum Analyzer. All measurements were done at 3 channels, 25, 600 and 1175 (low, middle and high operational frequency range.)
- b. The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer. This splitter loss and cable loss are the worst loss 5dB in the transmitted path track.
- c. The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. FCC 24.238(b) required a measurement bandwidth is the fundamental emission below 26dB bandwidth.



4.3.5 TEST RESULTS

For SO55:

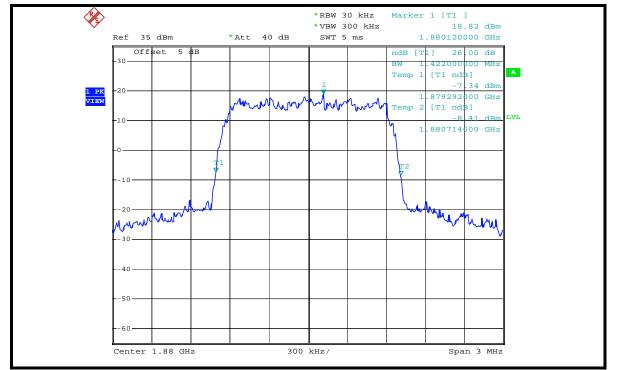
FREQUENCY (MHz)	MAX. OUTPUT POWER -26 dBc BANDWIDTH (MHz)	
1851.25	1.404	
1880.00	1.422	
1908.75	1.440	

CH 25 MAX. POWER

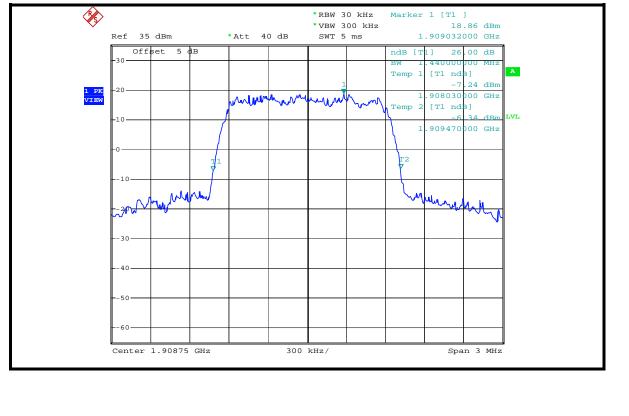




CH 600 MAX. POWER



CH 1175 MAX. POWER

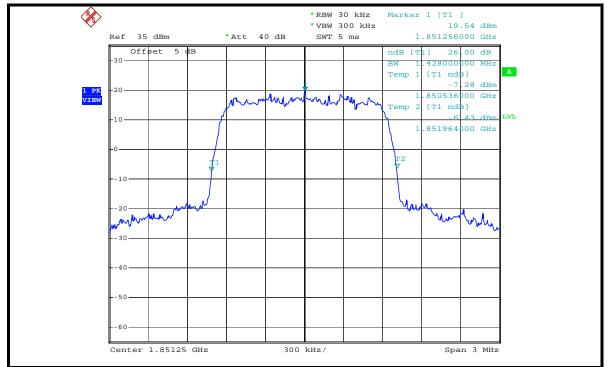




For EV-DO FTAP:

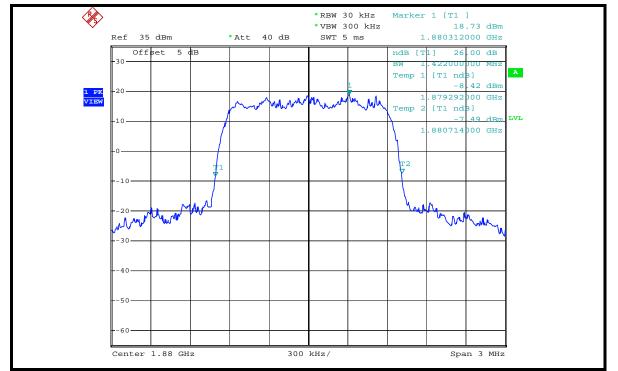
FREQUENCY (MHz)	MAX. OUTPUT POWER -26 dBc BANDWIDTH (MHz)		
1851.25	1.428		
1880.00	1.422		
1908.75	1.434		

CH 25 MAX. POWER

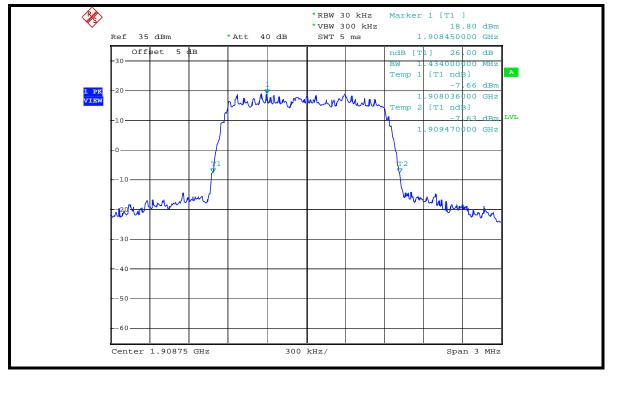




CH 600 MAX. POWER



CH 1175 MAX. POWER

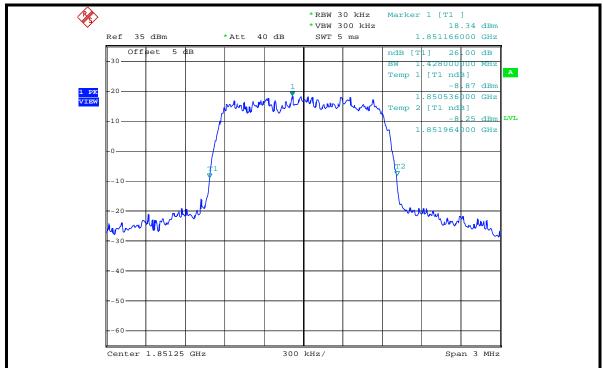




For EV-DO RTAP:

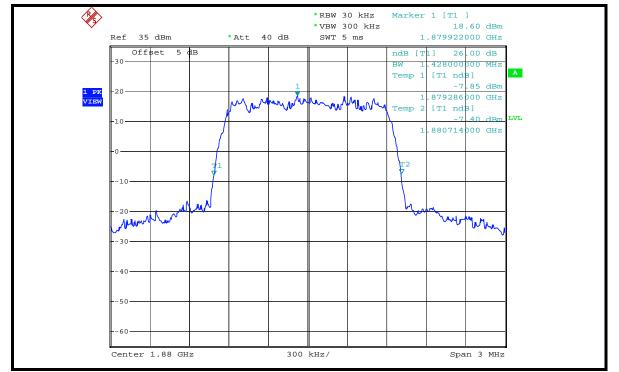
FREQUENCY (MHz)	MAX. OUTPUT POWER -26 dBc BANDWIDTH (MHz)	
1851.25	1.428	
1880.00	1.428	
1908.75	1.434	

CH 25 MAX. POWER

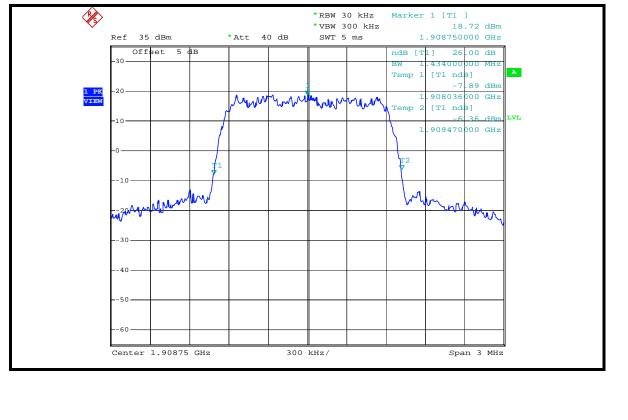




CH 600 MAX. POWER



CH 1175 MAX. POWER





4.4 BAND EDGE MEASUREMENT

4.4.1 LIMITS OF BAND EDGE MEASUREMENT

The PCS frequency bands refer to the FCC 24.229 rule. According to FCC 24.238(a) specified that power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB. In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

4.4.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
* ROHDE & SCHWARZ	E4446A	MY44360128	Dec. 03, 2007
Spectrum Analyzer			
* Mini-Circuits Power Splitter	ZAPD-4	400005	NA
* Hewlett Packard RF cable	8120-6192	01428251	NA
* JFW 20dB attenuation	50HF-020-SMA	NA	NA
* Suhner RF cable	Sucoflex104	204850/4	NA

NOTE: 1. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.

2. "*" = These equipments are used for the final measurement.

4.4.3 TEST SETUP

Same as Item 4.2.4 (Conducted Power Setup)



4.4.4 TEST PROCEDURES

- a. The EUT was set up for the maximum peak power with CDMA link data modulation. The power was measured with R&S Spectrum Analyzer. All measurements were done at 2 channels, 25 and 1175 (low and high operational frequency range.)
- b. The band edge measurement used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer. This splitter loss and cable loss are the worst loss 5dB in the transmitted path track.
- c. The center frequency of spectrum is the band edge frequency and span is 3 MHz. RB of the spectrum is 15kHz and VB of the spectrum is 15kHz.
- d. Record the max trace plot into the test report.

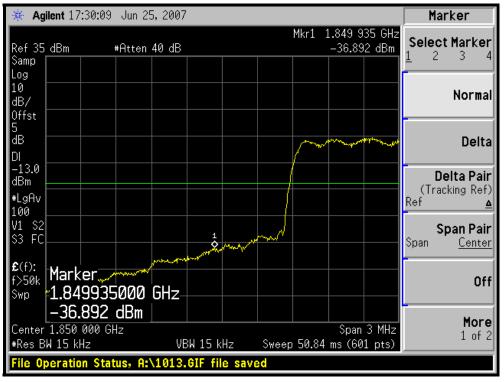
4.4.5 EUT OPERATING CONDITION

- a. The EUT makes a phone call to the communication simulator.
- b. The communication simulator station system controlled an EUT to export maximum output power under transmission mode and specific channel frequency.



4.4.6 TEST RESULTS

LOWER BAND EDGE



HIGHER BAND EDGE





4.5 CONDUCTED SPURIOUS EMISSIONS

4.5.1 LIMITS OF CONDUCTED SPURIOUS EMISSIONS MEASUREMENT

In the FCC 24.238(a), On any frequency outside a licensee's frequency block within USPCS spectrum, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 +10 log (P) dB. The specified minimum attenuation becomes 43dB and the limit of emission equal to -13dBm.

4.5.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
* ROHDE & SCHWARZ Spectrum Analyzer	FSP40	100035	Mar. 25, 2008
* Wainwright Instruments Band Reject Filter	WRCG1850/1910-18 30/1930-60/10SS	SN1	NA
* Wainwright Instruments High Pass Filter	WHK3.1/18G-10SS	SN1	NA
* Mini-Circuits Power Splitter	ZAPD-4	400005	NA
* Hewlett Packard RF cable	8120-6192	01428251	NA
* JFW 20dB attenuation	50HF-020-SMA	NA	NA
* Suhner RF cable	Sucoflex104	204850/4	NA

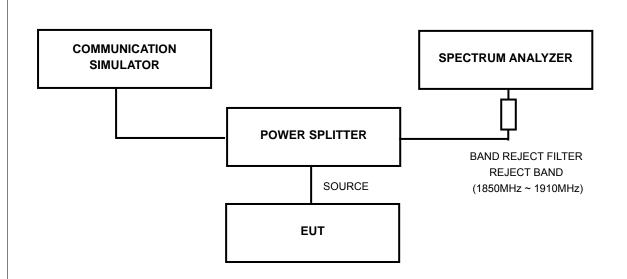
NOTE: 1. The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.

2. "*" = These equipments are used for the final measurement.



4.5.3 TEST PROCEDURE

- a. The EUT was set up for the maximum peak power with CDMA link data modulation. The power was measured with R&S Spectrum Analyzer. All measurements were done at 3 channels, 25, 600 and 1175 (low, middle and high operational frequency range.)
- b. The conducted spurious emission used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer. This splitter loss and cable loss are the worst loss 5dB in the transmitted path track.
- c. When the spectrum scanned from 9kHz to 3GHz, it shall be connected to the band reject filter attenuated the carried frequency. The spectrum set RB/VB 1MHz.
- d. When the spectrum scanned from 3GHz to 20GHz, it shall be connected to the high pass filter attenuated the carried frequency. The spectrum set RB/VB 1MHz.



4.5.4 TEST SETUP

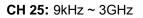
4.5.5 EUT OPERATING CONDITIONS

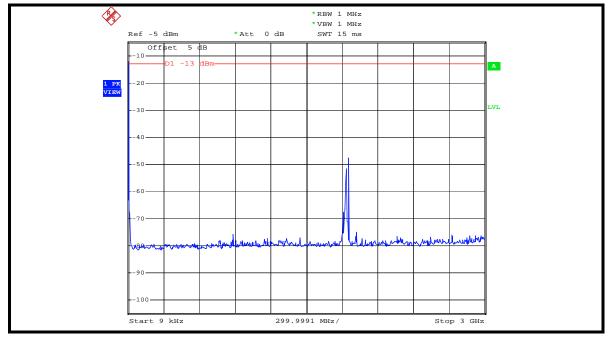
- a. The EUT makes a phone call to the communication simulator.
- b. The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency.

Report No.: RF960621L09-1

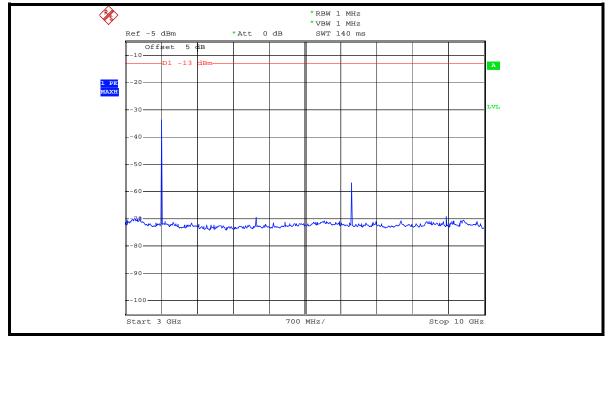


4.5.6 TEST RESULTS











A

LVL

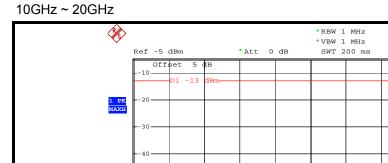
1mm

And

Stop 20 GHz

man

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mun

m

mound

1 GHz/

-50

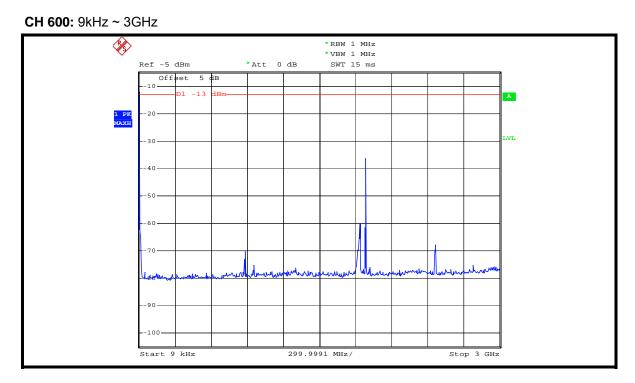
70 —

80

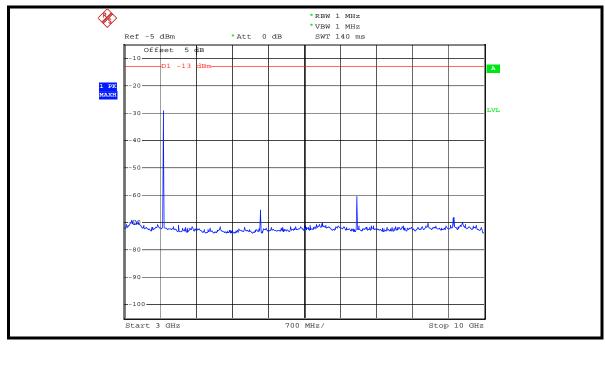
90

Start 10 GHz

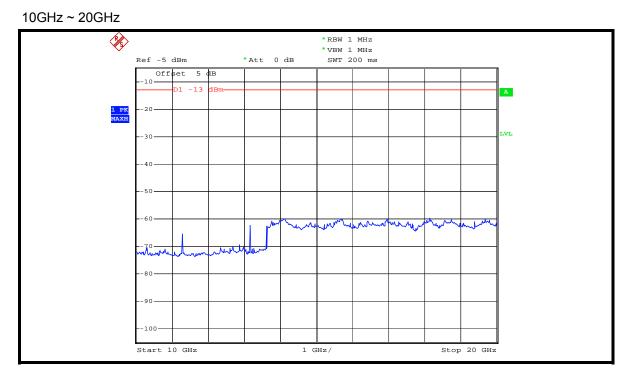




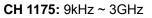


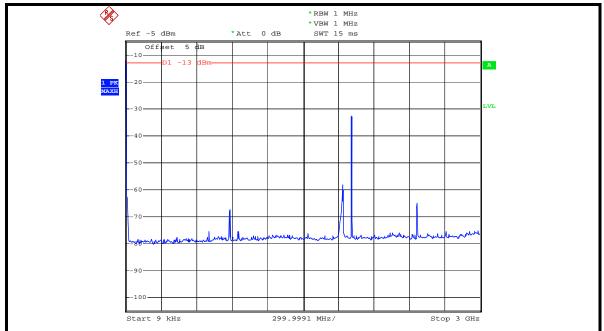




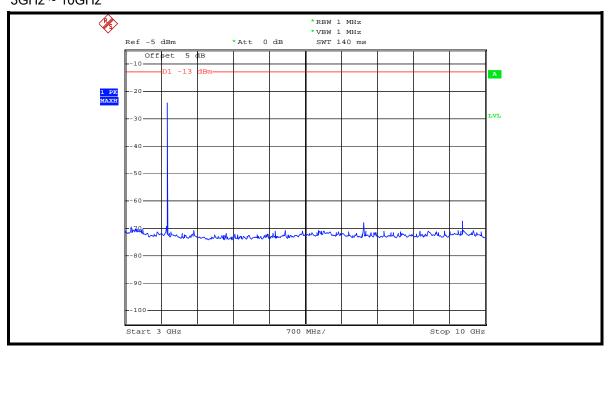




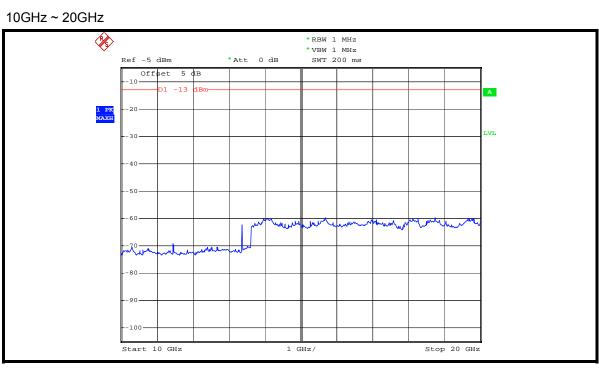














4.6 RADIATED EMISSION MEASUREMENT (BELOW 1GHz)

4.6.1 LIMITS OF RADIATED EMISSION MEASUREMENT

In the FCC 24.238(a), On any frequency outside a licensee's frequency block within USPCS spectrum, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 +10 log (P) dB. The specified minimum attenuation becomes 43dB and the limit of emission equal to -13dBm. So the limit of emission is the same absolute specified line.

LIMIT (dBm)	EQUIVALENT FIELD STRENGTH AT 3m (dBuV/m) (NOTE)
-13	82.22

NOTE: The following formula is used to convert the equipment radiated power to field strength.

E = [1000000 $\sqrt{(30P)}$] / 3 uV/m, where P is Watts.



4.6.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
Test Receiver ROHDE & SCHWARZ	ESCI	100424	Aug 04, 2007
Spectrum Analyzer ROHDE & SCHWARZ	FSP40	100025	Oct. 05, 2007
BILOG Antenna SCHWARZBECK	VULB9168	9168-160	May 31, 2008
HORN Antenna SCHWARZBECK	9120D	9120D-209	Jun. 28, 2008
HORN Antenna SCHWARZBECK	BBHA 9170	BBHA9170243	Dec. 28, 2007
Preamplifier Agilent	8447D	2944A10633	Oct. 26, 2007
Preamplifier Agilent	8449B	3008A01964	Oct. 26, 2007
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	238137/4	Dec. 11, 2007
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	233233/4	Nov. 14, 2007
Software ADT.	ADT_Radiated_V7.6	NA	NA
Antenna Tower inn-co GmbH	MA 4000	013303	NA
Antenna Tower Controller inn-co GmbH	CO2000	017303	NA
Turn Table ADT.	TT100.	TT93021703	NA
Turn Table Controller ADT.	SC100.	SC93021703	NA
Signal Generator Agilent	E8257C	MY43320668	Dec. 28, 2007

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Chamber 3.

3. The horn antenna and HP preamplifier (model: 8449B) are used only for the measurement of emission frequency above 1GHz if tested.

4. The VCCI Site Registration No. is R-237.

5. The IC Site Registration No. is IC3789B-3.



4.6.3 TEST PROCEDURES

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the receiving antenna, which was mounted on antenna tower and its position at 0.8 m above the ground.
- c. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading and recorded the value.
- d. Repeat step a \sim c for horizontal polarization.

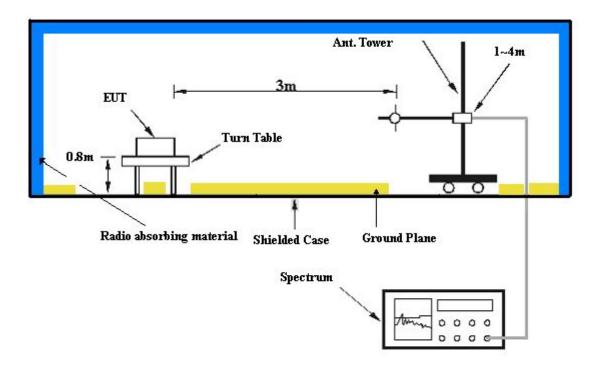
NOTE: The resolution bandwidth of spectrum analyzer is 1 MHz and the video bandwidth is 1 MHz.

4.6.4 DEVIATION FROM TEST STANDARD

No deviation



4.6.5 TEST SETUP



For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.6.6 EUT OPERATING CONDITIONS

- a. The EUT makes a phone call to the communication simulator.
- b. The communication simulator station system controlled an EUT to export maximum output power under transmission mode and specific channel frequency.



4.6.7 TEST RESULTS

MODE	TX channel 25	DETECTOR FUNCTION	Quasi-Peak
FREQUENCY RANGE	Below 10001/1Hz	INPUT POWER (SYSTEM)	120Vac, 60Hz
ENVIRONMENTAL CONDITIONS	24deg. C, 68%RH, 991hPa	TESTED BY	Match Tsui

	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M									
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)		
1	718.18	24.03 QP	82.22	-58.19	1.50 H	208.00	-0.69	24.72		
2	749.29	27.18 QP	82.22	-55.04	1.00 H	283.00	1.55	25.63		
3	766.79	25.27 QP	82.22	-56.95	1.00 H	10.00	-0.46	25.73		
4	807.62	26.72 QP	82.22	-55.50	1.50 H	313.00	0.68	26.05		
5	825.11	28.52 QP	82.22	-53.70	1.50 H	7.00	2.09	26.42		
6	873.72	27.50 QP	82.22	-54.72	1.00 H	22.00	0.24	27.26		
7	906.77	27.71 QP	82.22	-54.51	2.00 H	304.00	0.01	27.70		
8	937.88	28.19 QP	82.22	-54.03	1.50 H	196.00	0.04	28.14		

	ANTENNA POLARITY & TEST DISTANCE: VERTICAL AT 3 M									
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)		
1	681.24	24.31 QP	82.22	-57.91	1.50 V	196.00	0.34	23.97		
2	743.45	24.78 QP	82.22	-57.44	2.00 V	127.00	-0.68	25.46		
3	760.95	24.83 QP	82.22	-57.39	2.50 V	109.00	-0.87	25.70		
4	805.67	25.69 QP	82.22	-56.53	1.50 V	136.00	-0.32	26.01		
5	825.11	32.25 QP	82.22	-49.97	1.00 V	355.00	5.82	26.42		
6	871.78	26.87 QP	82.22	-55.35	1.00 V	289.00	-0.37	27.24		
7	893.16	27.50 QP	82.22	-54.72	1.50 V	280.00	-0.01	27.51		
8	937.88	28.22 QP	82.22	-54.00	2.00 V	301.00	0.07	28.14		

NOTE:

1. Emission level (dBuV/m) = Raw Value (dBuV) + Correction Factor (dB).

2. Correction Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB).

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.

5. This is valid for all 3 channels.



4.7 EFFECTIVE RADIATED POWER MEASUREMENT (ABOVE 1GHz)

4.7.1 LIMITS OF RADIATED EMISSION MEASUREMENT

In the FCC 24.238(a), On any frequency outside a licensee's frequency block within USPCS spectrum, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 +10 log (P) dB. The specified minimum attenuation becomes 43dB and the limit of emission equal to -13dBm.



4.7.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
Test Receiver ROHDE & SCHWARZ	ESCI	100424	Aug 04, 2007
Spectrum Analyzer ROHDE & SCHWARZ	FSP40	100025	Oct. 05, 2007
BILOG Antenna SCHWARZBECK	VULB9168	9168-160	May 31, 2008
HORN Antenna SCHWARZBECK	9120D	9120D-209	Jun. 28, 2008
HORN Antenna SCHWARZBECK	BBHA 9170	BBHA9170243	Dec. 28, 2007
Preamplifier Agilent	8447D	2944A10633	Oct. 26, 2007
Preamplifier Agilent	8449B	3008A01964	Oct. 26, 2007
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	238137/4	Dec. 11, 2007
RF signal cable HUBER+SUHNNER	SUCOFLEX 104	233233/4	Nov. 14, 2007
Software ADT.	ADT_Radiated_V7.6	NA	NA
Antenna Tower inn-co GmbH	MA 4000	013303	NA
Antenna Tower Controller inn-co GmbH	CO2000	017303	NA
Turn Table ADT.	TT100.	TT93021703	NA
Turn Table Controller ADT.	SC100.	SC93021703	NA
Signal Generator Agilent	E8257C	MY43320668	Dec. 28, 2007

NOTE: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Chamber 3.

3. The horn antenna and HP preamplifier (model: 8449B) are used only for the measurement of emission frequency above 1GHz if tested.

4. The VCCI Site Registration No. is R-237.

5. The IC Site Registration No. is IC3789B-3.



4.7.3 TEST PROCEDURES

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the receiving antenna, which was mounted on antenna tower and its position at 0.8 m above the ground.
- c. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading and recorded the value.
- d. The EUT is replaced by a horn antenna connected to a signal generator tuned to the frequency of emission.
- e. The signal generator level has to be adjusted to have the same emission nature.
- f. The radiated power can be calculated via the factor and antenna gain.
- g. Repeat step a ~ f for horizontal polarization.

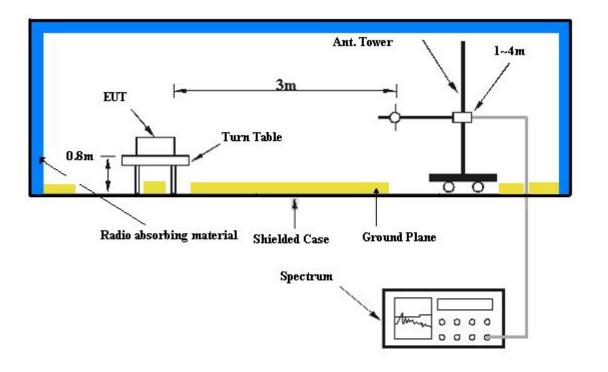
NOTE: The resolution bandwidth of spectrum analyzer is 1 MHz and the video bandwidth is 1 MHz.

4.7.4 DEVIATION FROM TEST STANDARD

No deviation



4.7.5 TEST SETUP



For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.7.6 EUT OPERATING CONDITIONS

- a. The EUT makes a phone call to the communication simulator.
- b. The communication simulator station system controlled an EUT to export maximum output power under transmission mode and specific channel frequency.



4.7.7 TEST RESULTS

MODE	Channel 25	FREQUENCY RANGE	Above 1000MHz
INPUT POWER (SYSTEM)	120Vac 60Hz	ENVIRONMENTAL CONDITIONS	25deg. C, 71%RH, 983hPa
TESTED BY	Lori Chiu		

	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M								
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV)	LIMIT (dBm)	S.G POWER VALUE (dBm)	CORRECTION FACTOR (dB)	POWER VALUE (dBm)			
1	3702.50	53.14	-13.00	-52.21	10.12	-42.09			
2	5553.75	49.63	-13.00	-57.09	11.49	-45.60			
3	7405.00	56.26	-13.00	-51.47	12.50	-38.97			

	ANTENNA POLARITY & TEST DISTANCE: VERTICAL AT 3 M								
NO.	FREQ. (MHz)	EMISSION LIMIT (dBm) S.G POWER CORRECTION PO LEVEL (dBuV) LIMIT (dBm) VALUE (dBm) FACTOR (dB) PO			POWER VALUE (dBm)				
1	3702.50	49.52	-13.00	-55.83	10.12	-45.71			
2	5553.75	47.67	-13.00	-59.05	11.49	-47.56			
3	7405.00	60.67	-13.00	-47.06	12.50	-34.56			

NOTE: Power Value (dBum) = S.G Power Value (dBm) + Correction Factor (dB).



MODE	Channel 600	FREQUENCY RANGE	Above 1000MHz
INPUT POWER (SYSTEM)	120Vac, 60Hz	ENVIRONMENTAL CONDITIONS	25deg. C, 71%RH, 983hPa
TESTED BY	Lori Chiu		

	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M							
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV)	LIMIT (dBm)	S.G POWER VALUE (dBm)	CORRECTION FACTOR (dB)	POWER VALUE (dBm)		
1	3760.00	60.67	-13.00	-44.68	10.12	-34.56		
2	5640.00	51.20	-13.00	-55.52	11.49	-44.03		
3	7520.00	56.76	-13.00	-50.97	12.50	-38.47		

	ANTENNA POLARITY & TEST DISTANCE: VERTICAL AT 3 M								
N	10.	FREQ. (MHz)	EMISSION LEVEL (dBuV)	LIMIT (dBm)	S.G POWER VALUE (dBm)	CORRECTION FACTOR (dB)	POWER VALUE (dBm)		
	1	3760.00	60.16	-13.00	-45.19	10.12	-35.07		
	2	5640.00	49.30	-13.00	-57.42	11.49	-45.93		
	3	7520.00	58.18	-13.00	-49.55	12.50	-37.05		

NOTE: Power Value (dBum) = S.G Power Value (dBm) + Correction Factor (dB).



MODE	Channel 1175	FREQUENCY RANGE	Above 1000MHz
INPUT POWER (SYSTEM)	120Vac, 60Hz	ENVIRONMENTAL CONDITIONS	25deg. C, 71%RH, 983hPa
TESTED BY	Lori Chiu		

ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M						
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV)	LIMIT (dBm)	S.G POWER VALUE (dBm)	CORRECTION FACTOR (dB)	POWER VALUE (dBm)
1	3817.50	65.84	-13.00	-39.51	10.12	-29.39
2	5726.25	56.77	-13.00	-49.95	11.49	-38.46
3	7635.00	57.50	-13.00	-50.23	12.50	-37.73

	ANTENNA POLARITY & TEST DISTANCE: VERTICAL AT 3 M					
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV)	LIMIT (dBm)	S.G POWER VALUE (dBm)	CORRECTION FACTOR (dB)	POWER VALUE (dBm)
1	3817.50	64.57	-13.00	-40.78	10.12	-30.66
2	5726.25	55.58	-13.00	-51.14	11.49	-39.65
3	7635.00	58.69	-13.00	-49.04	12.50	-36.54

NOTE: Power Value (dBum) = S.G Power Value (dBm) + Correction Factor (dB).



5 INFORMATION ON THE TESTING LABORATORIES

We, ADT Corp., were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

USA	FCC, UL, A2LA
GERMANY	TUV Rheinland
JAPAN	VCCI
NORWAY	NEMKO
CANADA	INDUSTRY CANADA, CSA
R.O.C.	TAF, BSMI, NCC
NETHERLANDS	Telefication
SINGAPORE	PSB , GOST-ASIA (MOU)
RUSSIA	CERTIS (MOU)

Copies of accreditation certificates of our laboratories obtained from approval agencies can be downloaded from our web site: <u>www.adt.com.tw/index.5/phtml</u>. If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab: Tel: 886-2-26052180 Fax: 886-2-26051924 Hsin Chu EMC/RF Lab: Tel: 886-3-5935343 Fax: 886-3-5935342

Hwa Ya EMC/RF/Safety/Telecom Lab: Web Site: www.adt.com.tw Tel: 886-3-3183232 Fax: 886-3-3185050

The address and road map of all our labs can be found in our web site also.



6 APPENDIX A – MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB

No any modifications are made to the EUT by the lab during the test.